

Tutorial on time-variant reliability analysis

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Time-variant reliability: definitions

At time t , the structure can be characterized by its resistance (or, capacity), $R(t)$, and the load (or, demand) on the structure, $S(t)$. $R(t)$ and $S(t)$ are random variables.

- One can define a point-in-time failure event as

$$F^*(t) = \{M(t) \leq 0\} = \{R(t) \leq S(t)\}$$

where $M(t) = R(t) - S(t)$ is the safety margin.

- More generally, the structure can be modelled by a limit state function $g(\mathbf{Y}, t)$, where \mathbf{Y} is comprised of all random variables and random processes in the problem. Then

$$F^*(t) = \{g(\mathbf{Y}, t) \leq 0\} .$$

Time-variant reliability: definitions (2)

To compute the time-variant reliability, one must consider the random processes $\{R(\tau)\}_{\tau \in [0, T]}$ and $\{S(\tau)\}_{\tau \in [0, T]}$, and account for all point-in-time failure events up to time T .

- The failure event for a given time duration $[0, T]$ is defined as:

$$F(T) = \{\exists \tau \in [0, T]: R(\tau) \leq S(\tau)\}$$

- The time-variant structural reliability is given by:

$$\mathbb{L}(0, T) = \Pr\{R(t) > S(t), \forall t \in [0, T]\} = 1 - \Pr\{F(T)\}.$$

- Using the more general definition, the probability of a failure up to time T is given by:

$$P_F(0, T) = \Pr\{F(T)\} = \Pr\{\min_{0 \leq \tau \leq T} g(\mathbf{Y}, \tau) \leq 0\}.$$

Time-dependent reliability: basic approaches

- **Time-integrated approach**: the whole service period $[0, T]$ of the structure is considered as a single time unit. The reliability is computed based on statistical properties of the random variables that relate to the whole service period.
- **Discretized approach**: Shorter time intervals, such as a year or duration of a storm, are considered. The reliability within each time unit is estimated based on extreme value theory. Failure probability over the whole service period $[0, T]$ is then determined (approximately) from the interval failure probabilities.
- **Out-crossing theory based approach**: The structural failure event is viewed as an outcrossing event of a random process. “Outcrossing” implies that the safety margin process $M(t) = R(t) - S(t)$, or the random process $g(\mathbf{Y}, \tau)$, becomes zero or less in the period $[0, T]$. We estimate the first-passage probability, i.e., the probability that $M(t) \leq 0$ occurs during $[0, T]$ using random process theory.

Time-integrated approach

We consider a case in which every realization of $S(t)$ is non-decreasing and every realization of $R(t)$ is non-increasing.

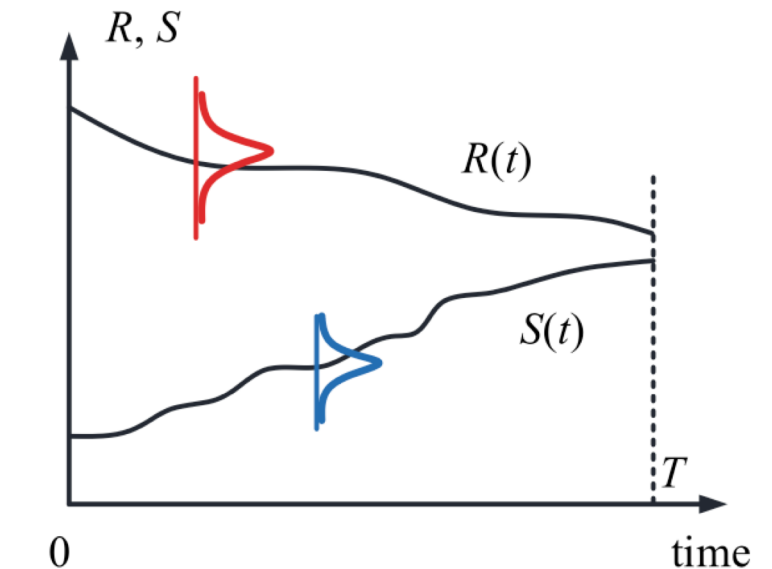
In this case, it is reasonable to compare the R_{min} with S_{max} , both occurring at time $t = T$.

An instantaneous estimate of the failure probability at time t is given by:

$$\Pr\{F^*(t)\} = \Pr\{R(t) < S(t)\}$$

In this case, $P_F(0, T) = \Pr\{F^*(T)\}$. This probability can be computed by time-invariant reliability methods.

This approach is applicable to the general case, if $g(\mathbf{Y}, t)$ is monotonically non-increasing, e.g., $g(\mathbf{Y}, t) = D_{cr} - h_d(\mathbf{Y}, t)$ where $h_d(\mathbf{Y}, t)$ is a deterioration model and D_{cr} is the deterioration limit.



Example 1

Consider a steel plate subjected to corrosion. Failure occurs when the corrosion loss exceeds the plate thickness w .

The limit state function is $g(\mathbf{Y}, t) = w - A(t - C)$, where $\mathbf{Y} = [A, C]$. A represents the corrosion rate and C denotes the coating life.

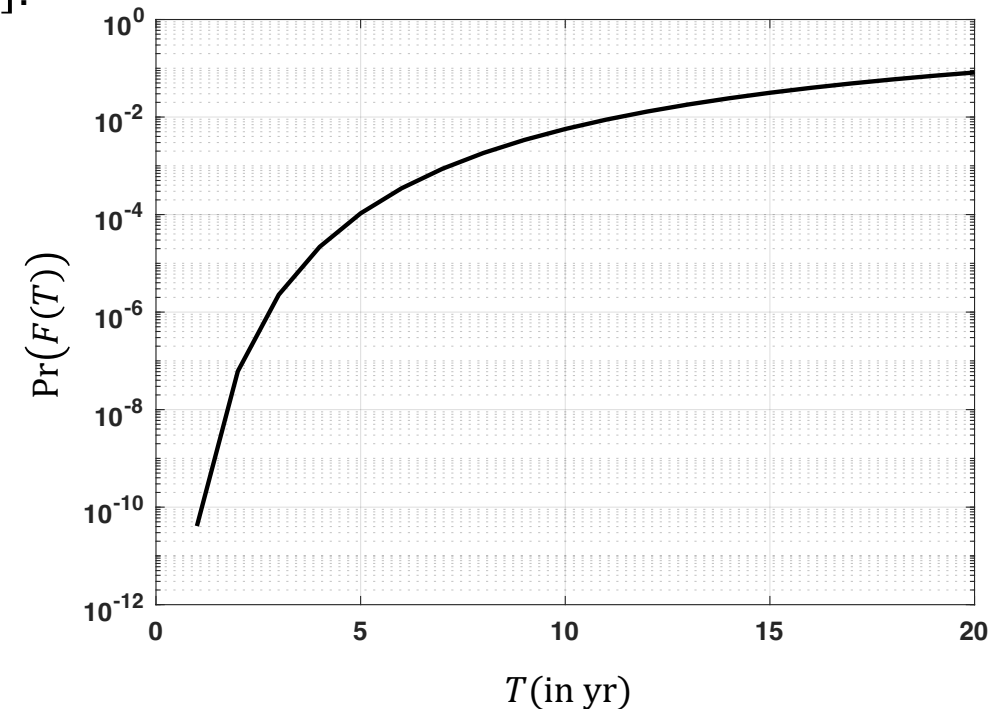
A, C : Lognormal random variables, independent

$\mu_A = 0.6$ mm/yr (mean), $\sigma_A = 0.5$ mm/yr (standard deviation)

$\mu_C = 5.0$ yr, $\sigma_C = 5.0$ yr

$$\Pr(F(T)) = \Pr(F^*(T)) = \Pr\{g(\mathbf{Y}, T) \leq 0\}$$

Exact solution possible through numerical intergration



Reference: Straub D., Schneider R., Bismut E. and Kim H.Y. Reliability analysis of deteriorating structural systems. Structural Safety, Volume 82, 2020, Article 101877.

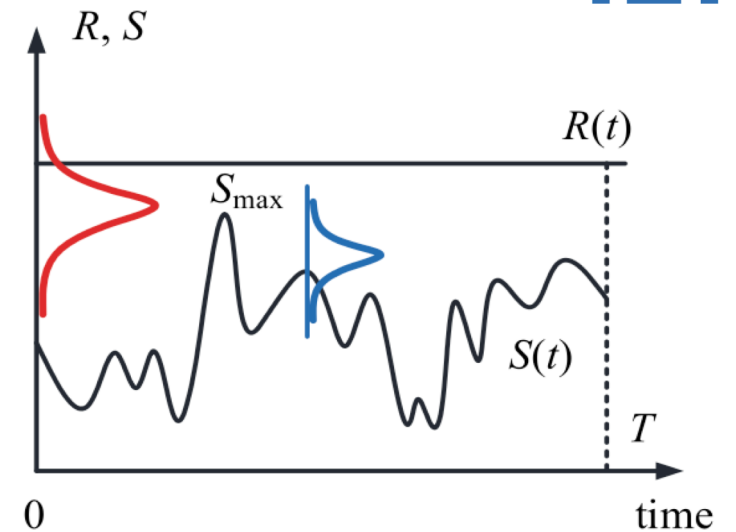
Time-integrated approach (2)

The monotonicity assumption on $S(t)$ may not hold in general.

Consider the R-S problem. If $R(t) \equiv R$:

$$P_F(0, T) = \Pr(R < S_{max}),$$

where $S_{max} = \max\{S(t) | t \in [0, T]\}$.



If a suitable model for the CDF $F_{S_{max}}(\cdot)$ of S_{max} is available, then $P_F(0, T)$ can be evaluated by time-invariant reliability methods.

If $R(t)$ is time-variant, or, more generally, if $g(\mathbf{Y}, t)$ shows random fluctuations in time, advanced methods based on out-crossing theory or Monte Carlo simulation are typically required to evaluate $P_F(0, T)$.

Image Source: Wang C. Structural reliability and time-dependent reliability. 2021 Springer series in reliability engineering, Springer Cham.
DOI <https://doi.org/10.1007/978-3-030-62505-4> .

Discretized approach

- Divide the whole service period $[0, T]$ into multiple time units $0 = t_0 < t_1 < \dots < t_m = T$
- A common choice is yearly intervals, but a finer discretization is adopted if the service life is short
- Define interval failure events $F_j^* = \left\{ \min_{\tau \in (t_{j-1}, t_j]} R(\mathbf{Y}_R, \tau) - S(\tau) \leq 0 \right\}; j = 1, \dots, m$; random variables \mathbf{Y}_R that determine resistance are separable from those that determine the load effects.
- $R(t)$ is monotonically non-increasing.

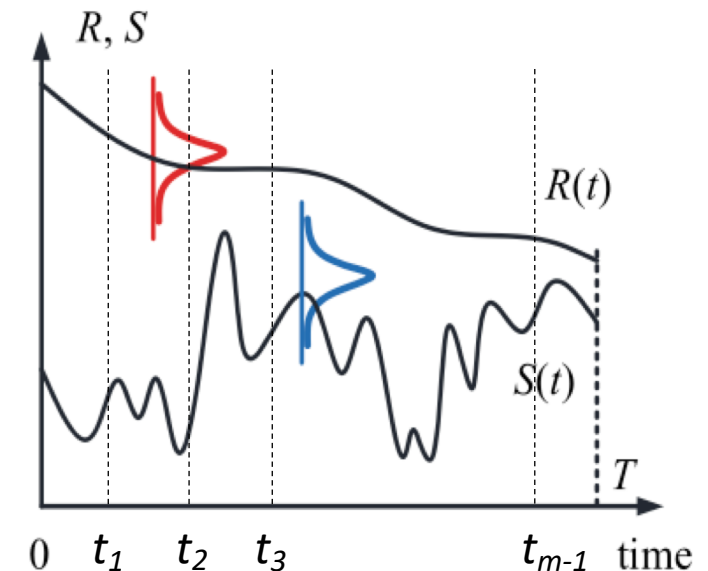
- Interval failure probability:

$$\Pr(F_j^*) \approx \Pr(R(\mathbf{Y}_R, t_j) \leq S_{max,j}) \quad (\text{conservative})$$

$$S_{max,j} = \max\{S(t) | t \in (t_{j-1}, t_j]\}.$$

$$\text{maximum error } \Pr(R(\mathbf{Y}_R, t_j) \leq S_{max,j}) - \Pr(R(\mathbf{Y}_R, t_{j-1}) \leq S_{max,j})$$

- $\Pr(F_j^*)$ can be estimated by time-invariant reliability analysis.



Discretized approach (2)

- In the general case $\mathbf{Y} = \{\mathbf{Y}_R, \mathbf{S}_{ti}, \mathbf{S}(t)\}$, where \mathbf{S}_{ti} is the vector of time-invariant load effects and $\mathbf{S}(t)$ is the vector of time-variant load effects.
- Interval failure events: $F_j^* = \left\{ \min_{\tau \in (t_{j-1}, t_j]} g(\mathbf{Y}_R, \mathbf{S}_{ti}, \mathbf{S}(\tau), \tau) \leq 0 \right\}$.
- Interval failure probability: $\Pr(F_j^*) \approx \Pr(g(\mathbf{Y}_R, \mathbf{S}_{ti}, \mathbf{S}_{max,j}, t_j) \leq 0)$.
- The target failure event is a union of the interval failure events: $F(T) = \bigcup_{j=1}^m F_j^*$.
- Computation of $\Pr(F(T))$ requires accounting for the dependence between the interval failure events.
- Exact computation of $\Pr(F(T))$ requires solving a series system reliability problem.
- Series system bounds for $\Pr(F(T))$:

$$\max_{j=1, \dots, m} \Pr(F_j^*) \leq \Pr(F(T)) \leq \sum_{j=1}^m \Pr(F_j^*)$$

Monte Carlo simulation

- Simplest and most robust strategy to compute $\Pr(F(T)) = \Pr(\cup_{j=1}^m F_j^*)$
- Generate samples $\mathbf{Y}_R^{(k)}, \mathbf{s}_{ti}^{(k)}, \mathbf{s}_{max,1}^{(k)}, \dots, \mathbf{s}_{max,m}^{(k)}, k = 1, \dots, N$
- Estimate of the failure probability:

$$\Pr(F(T)) \approx \frac{1}{N} \sum_{k=1}^N \mathbb{I} \left\{ \left[\min_{j=1, \dots, m} g \left(\mathbf{Y}_R^{(k)}, \mathbf{s}_{ti}^{(k)}, \mathbf{s}_{max,j}^{(k)}, t_j \right) \right] \leq 0 \right\}$$

- Coefficient of variation of the estimate: $\delta = \sqrt{\frac{(1 - \Pr(F(T)))}{N \Pr(F(T))}}$
- Inefficient when computing small failure probabilities. Approximately, 10^8 samples are required to estimate a failure probability of $\Pr(F(T)) = 10^{-6}$ with a coefficient of variation of $\delta = 10\%$. Infeasible for problems with computationally expensive limit states.
- If the point-in-time failure probability is desirable, e.g., in the case of a monotonically decreasing limit state, it can be estimated based on this approach.

Evaluation of $\Pr(F_j^*)$ - First order reliability method

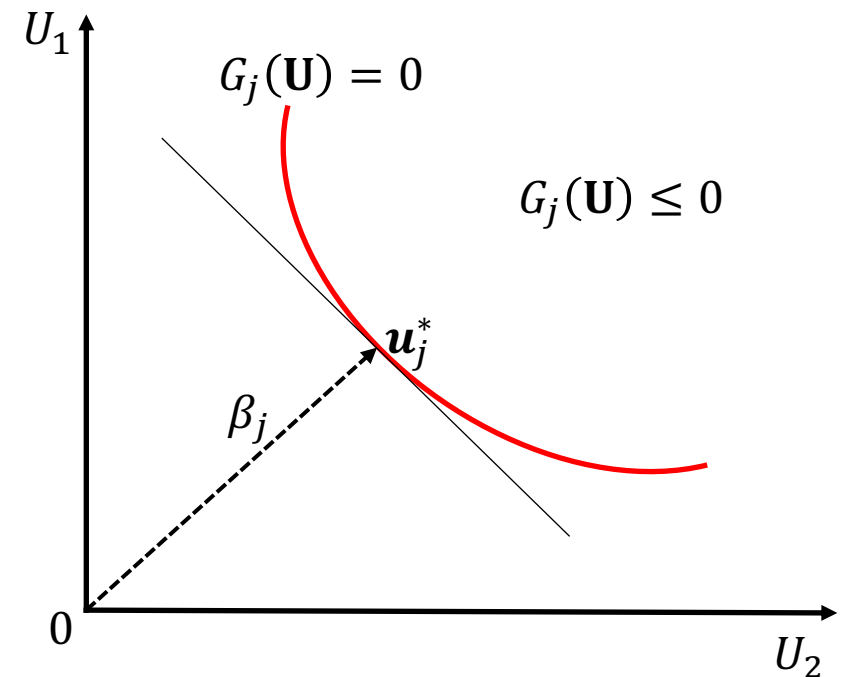
- Consider the interval failure probability $\Pr(F_j^*) = \Pr\{g_j(\mathbf{Y}) \leq 0\}$, where $g_j(\mathbf{Y}) = g(\mathbf{Y}_R, \mathbf{S}_{ti}, \mathbf{S}_{max,j}, t_j)$ and $\mathbf{Y} = [\mathbf{Y}_R, \mathbf{S}_{ti}, \mathbf{S}_{max,j}]$.
- Random vector \mathbf{Y} is transformed to uncorrelated standard normal random vector $\mathbf{U} = \mathbb{T}(\mathbf{Y})$ through isoprobabilistic transformations.
- The limit state is expressed in terms of \mathbf{U} : $G_j(\mathbf{U}) = g_j(\mathbb{T}^{-1}(\mathbf{U}))$
- FORM uses the design point \mathbf{u}_j^* in the \mathbf{U} - space:

$$\mathbf{u}_j^* = \operatorname{argmin} \|\mathbf{u}\|$$

$$\text{s.t. } G_j(\mathbf{U}) \leq 0.$$

where $\|\cdot\|$ is the Euclidean norm.

- $\Pr(F_j^*) \approx \Phi(-\beta_j)$ where, $\beta_j = \|\mathbf{u}_j^*\|$ is the reliability index.
- \mathbf{u}_j^* can be used as the starting point of numerical optimization to determine \mathbf{u}_{j+1}^* .



Evaluation of $\Pr(F_j^*)$ - First order reliability method (2)

FORM approximation linearizes the limit state function $G_j(\mathbf{U})$ at $\mathbf{U} = \mathbf{u}_j^*$, i.e.,

$$\Pr(F_j^*) = \Pr\{G_j(\mathbf{U}) \leq 0\} \approx \Pr\{G_j^l(\mathbf{U}) \leq 0\}$$

where,

$$G_j(\mathbf{U}) \approx G_j^l(\mathbf{U}) = G_j(\mathbf{u}_j^*) + \langle \nabla G_j(\mathbf{u}_j^*), (\mathbf{U} - \mathbf{u}_j^*) \rangle = \langle \nabla G_j(\mathbf{u}_j^*), (\mathbf{U} - \mathbf{u}_j^*) \rangle$$

• $G_j^l(\mathbf{U})$ is a normal random variable:

$$\circ \mu_j^l = E[G_j^l(\mathbf{U})] = -\langle \nabla G_j(\mathbf{u}_j^*), \mathbf{u}_j^* \rangle \text{ and } \sigma_j^l = \sqrt{\text{Var}[G_j^l(\mathbf{U})]} = \|\nabla G_j(\mathbf{u}_j^*)\|$$

$$\circ M_j = \frac{G_j^l(\mathbf{U}) - \mu_j^l}{\sigma_j^l} \text{ is a standard normal random variable}$$

$$\circ \text{If } \boldsymbol{\alpha}_j = \frac{\mathbf{u}_j^*}{\|\mathbf{u}_j^*\|}, \text{ then } \frac{\mu_j^l}{\sigma_j^l} = \langle \boldsymbol{\alpha}_j, \mathbf{u}_j^* \rangle = \|\mathbf{u}_j^*\| = \beta_j.$$

$$\circ \Pr\{G_j^l(\mathbf{U}) \leq 0\} = \Pr\{M_j \leq -\beta_j\} = \Phi(-\beta_j)$$

Evaluation of $\Pr(F(T)) = \Pr(\cup_{j=1}^m F_j^*)$ - extension of FORM

Recall that $F(T) = \cup_{j=1}^m F_j^*$

- $\Pr(\cup_{j=1}^m F_j^*) = 1 - \Pr(\cap_{j=1}^m F_j^{*c}) \approx 1 - \Pr(\cap_{j=1}^m \{M_j > -\beta_j\})$
- The random variables M_1, \dots, M_m are mutually correlated and jointly Gaussian.
- Since M_1, \dots, M_m have zero mean value, from symmetry we get

$$\Pr(F(T)) = 1 - \Pr(\cap_{j=1}^m F_j^{*c}) \approx 1 - \Phi_m(\boldsymbol{\beta}; \boldsymbol{\rho})$$

where $\Phi_m(\boldsymbol{\beta}; \boldsymbol{\rho})$ is the multivariate standard normal CDF with correlation matrix $\boldsymbol{\rho}$ evaluated

at $\boldsymbol{\beta} = (\beta_1, \dots, \beta_m)$. The element $[\boldsymbol{\rho}]_{j,k}$ is the correlation coefficient between M_j and M_k and is given by

$[\boldsymbol{\rho}]_{j,k} = E[M_j M_k]$. $[\boldsymbol{\rho}]_{j,k}$ can be computed from the form sensitivities α_j and α_k .

Evaluation of $\Pr(F_j^*)$ - Subset simulation

The probability $\Pr(F_j^*) = \Pr\{G_j(\mathbf{U}) \leq 0\}$ is formulated as a sequence of conditional probabilities:

$$\Pr\{G_j(\mathbf{U}) \leq 0\} = \prod_{k=1}^L \Pr\{G_j(\mathbf{U}) \leq b_k | G_j(\mathbf{U}) \leq b_{k-1}\} = \prod_{k=1}^L p_{k,k-1}$$

L is the number of subsets and the b_k are the intermediate thresholds with $\infty = b_0 \geq b_1 \geq \dots \geq b_L = 0$.

- The intermediate thresholds are selected so that the conditional probabilities are large, typically $\rho = 0.1$.
- The probability $p_{k,k-1}$ can be estimated (accurately) by the standard Monte Carlo method:

$$p_{k,k-1} \approx \frac{1}{N} \sum_{s=1}^N \mathbb{I}\{G_j(\mathbf{U}^{(s)}) \leq b_k\}$$

Samples $\mathbf{U}^{(s)}, s = 1, \dots, N$ are distributed according to the PDF $f_{\mathbf{U},k-1}(\mathbf{u}) = \frac{\mathbb{I}[G_j(\mathbf{u}) \leq b_{k-1}] f_{\mathbf{U}}(\mathbf{u})}{\Pr\{G_j(\mathbf{u}) \leq b_{k-1}\}}$, where $f_{\mathbf{U}}(\mathbf{u})$

is the nominal PDF of \mathbf{U} . The samples are generated through the Markov chain Monte Carlo method.

- During implementation, the thresholds are selected through an adaptive procedure.

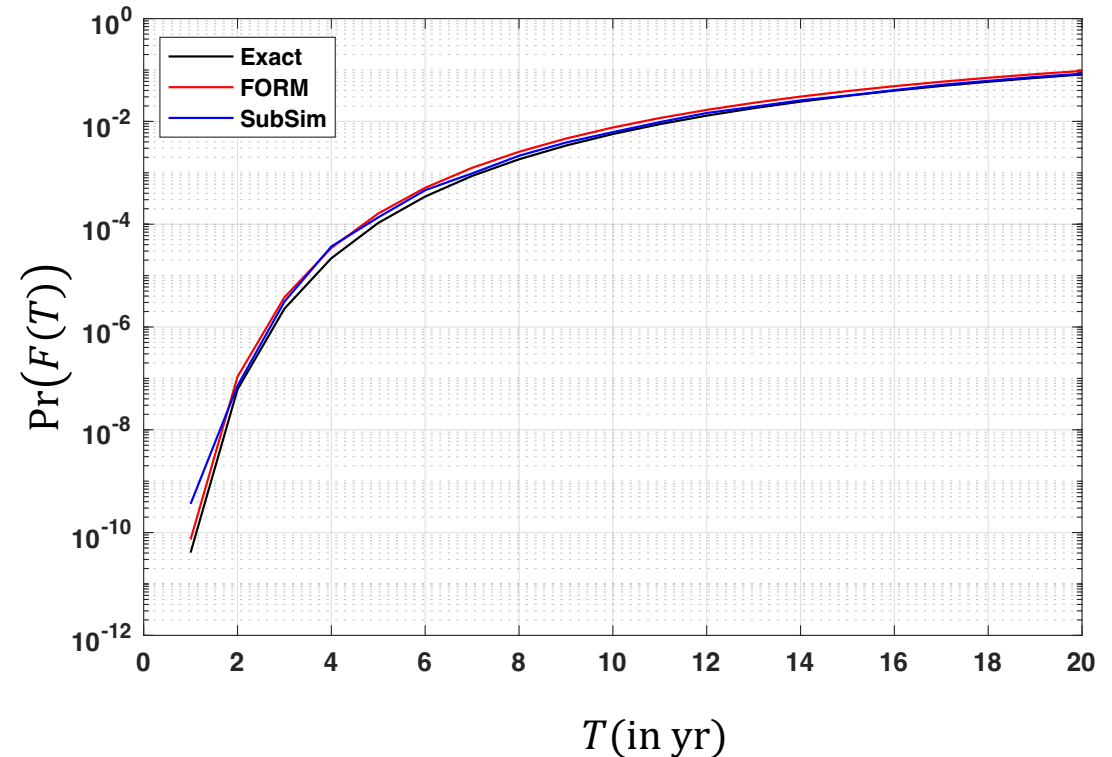
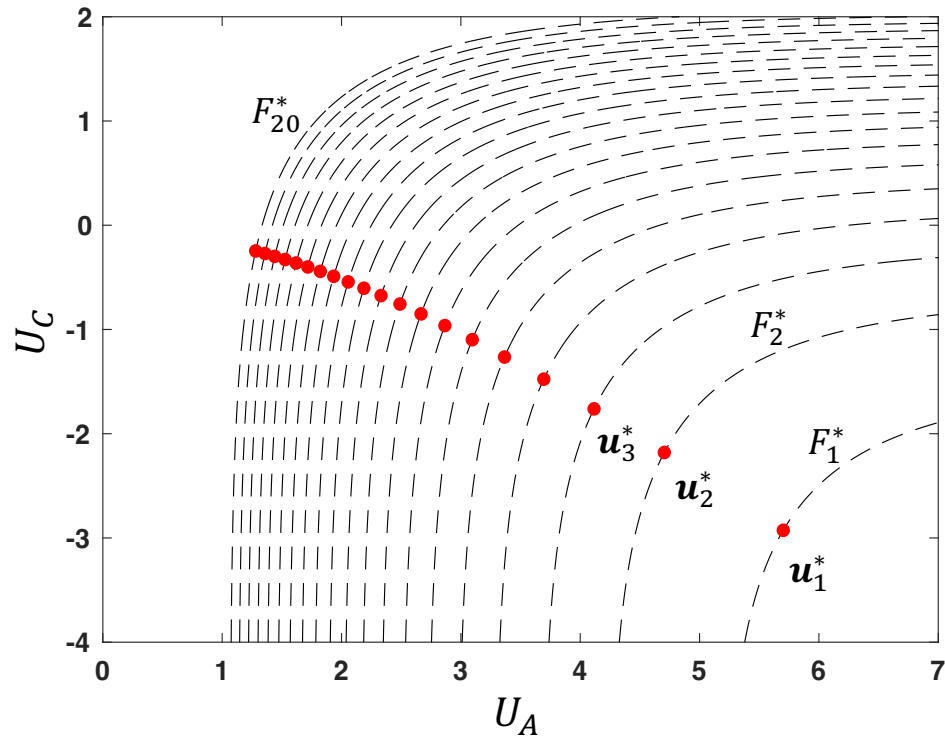
Reference: Au S.K. and Beck J.L. Estimation of small failure probabilities in high dimensions by subset simulation. Probabilistic Engineering Mechanics, Volume 16, 2001, pp. 263-277.

Example 1 - with FORM and subset simulation

Limit state function in the standard normal space:

$$G_j(\mathbf{U}) = w - e^{(\mu_{\ln A} + \sigma_{\ln A} U_A)} (t_j - e^{(\mu_{\ln C} + \sigma_{\ln C} U_C)}), \text{ where } \mathbf{U} = \{U_A, U_C\}.$$

Consider $t_1 = 1\text{yr}, t_2 = 2\text{yr}, \dots, t_{20} = 20\text{yr}$. In this example, $F_j^* = F^*(t_j) = F(t_j)$.



Example 1 - sequential subset simulation

For $t_1 < t_2 \dots < t_{20}$, we have $F_{20}^* \supseteq F_{19}^* \supseteq \dots \supseteq F_1^*$.

The sequence of failure probabilities $\Pr(F_1^*), \dots, \Pr(F_{20}^*)$ can be estimated through sequential subset simulation approach.

$$\Pr(F_j^*) = \Pr(F_{20}^*) \prod_{k=0}^{20-j-1} \Pr(F_{20-k-1}^* | F_{20-k}^*)$$

- The failure probability $\Pr(F_{20}^*)$ is estimated using the standard subset simulation approach.
- If $\Pr(F_{20-k-1}^* | F_{20-k}^*) \leq 0.1$, additional subset levels can be introduced between F_{20-k}^* and F_{20-k-1}^* , as in standard subset simulation.
- If $\Pr(F_{20-k-1}^* | F_{20-k}^*) \geq 0.1$, use the failure samples in F_{20-k}^* to estimate $\Pr(F_{20-k-1}^* | F_{20-k}^*)$, $\Pr(F_{20-k-2}^* | F_{20-k}^*)$, $\Pr(F_{20-k-3}^* | F_{20-k}^*)$, ..., $\Pr(F_{20-k-r}^* | F_{20-k}^*)$, until $\Pr(F_{20-k-r-1}^* | F_{20-k}^*) \leq 0.1$.
- Generate failure samples in F_{20-k-r}^* and continue the procedure.

Reference: Straub D., Schneider R., Bismut E. and Kim H.Y. Reliability analysis of deteriorating structural systems. Structural Safety, Volume 82, 2020, Article 101877.

Example 2

The capacity of a system is described by a linearized deterioration model:

$$R(t) = r_0 - At ,$$

the initial resistance $r_0 = 49.5\text{MPa}$ is deterministic and A is a normal random variable with mean $\mu_A = 0.2\text{MPa/yr}$ and standard deviation $\sigma_A = 0.2\text{MPa/yr}$.

The load effect is described by its annual maximum, $S_{max,j}$, which is i.i.d. for all years. $S_{max,j}$ is a normal random variable with mean $\mu_S = 40\text{MPa}$ and standard deviation $\sigma_S = 2\text{MPa}$.

$$F(T) = \cup_{j=1}^m F_j^* \text{ where } F_j^* = \left\{ \min_{\tau \in (t_{j-1}, t_j]} R(\tau) - S(\tau) \leq 0 \right\}, \text{ for yearly intervals } m = T \text{ and } t_1 = 1\text{yr}, t_2 = 2\text{yr}, \dots$$

Without deterioration:

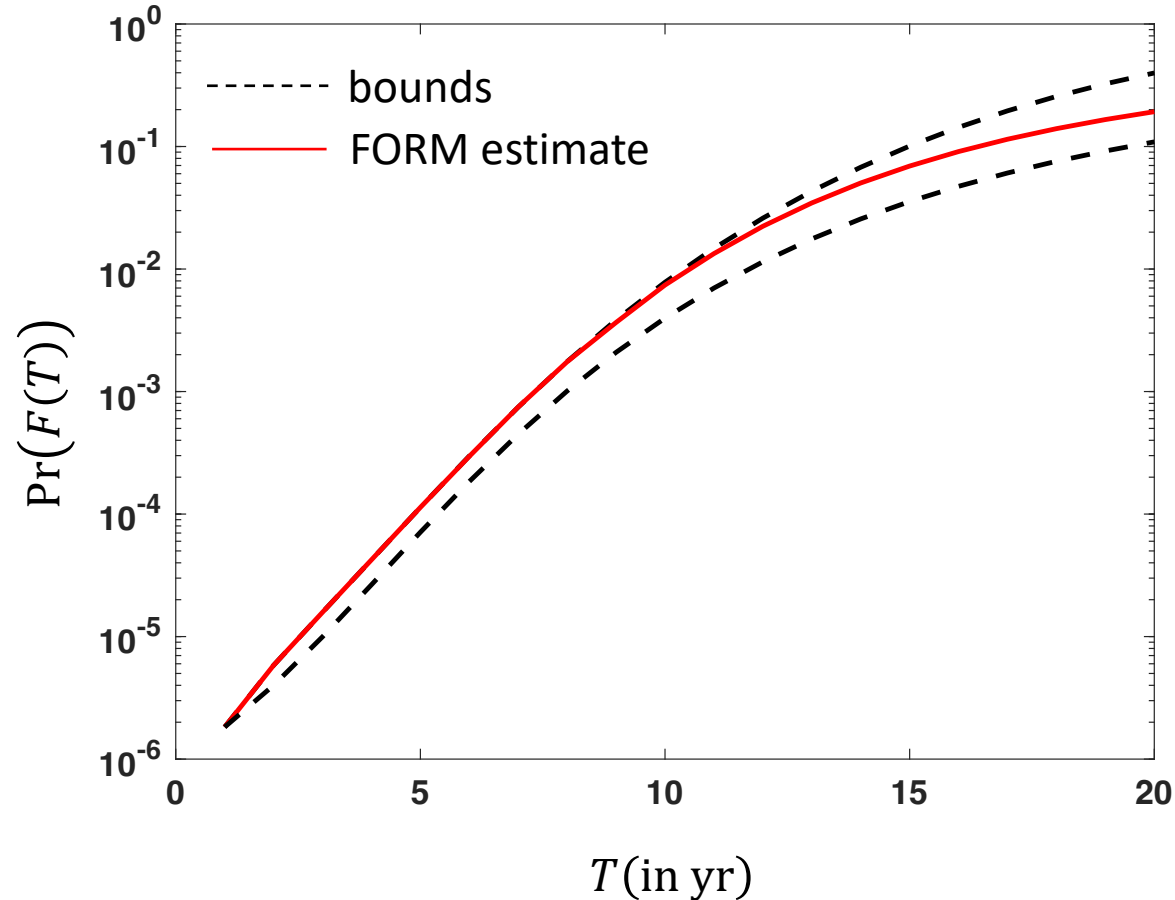
- Interval failure probability: $\Pr(F_j^*) = \Pr\{S_{max,j} > r_0\}$
- $\Pr(F(T)) = 1 - \prod_{j=1}^m \Pr(F_j^{*c}) = 1 - \left(F_{S_{max,j}}(r_0) \right)^m = 2 \cdot 10^{-5}$ for $T = 20\text{yr}$.

Example 2 (2)

With deterioration:

- Interval failure probability: $\Pr(F_j^*) \approx \Pr\{S_{max,j} > R(t_j)\} = \Pr\{g_j(\mathbf{Y}) \leq 0\}$, where $\mathbf{Y} = \{A, S_{max,j}\}$
and $g_j(\mathbf{Y}) = r_0 - At_j - S_{max,j}$.
- Limit state in the standard normal space: $G_j(\mathbf{U}) = (r_0 - \mu_A t_j - \mu_S) - t_j \sigma_A U_A - \sigma_S U_{S,j}$.
- Based on FORM:
 - Design point $\mathbf{u}_j^* = \left(\frac{t_j \sigma_A (r_0 - \mu_A t_j - \mu_S)}{t_j^2 \sigma_A^2 + \sigma_S^2}, \frac{\sigma_S (r_0 - \mu_A t_j - \mu_S)}{t_j^2 \sigma_A^2 + \sigma_S^2} \right)$.
 - $\beta_j = \|\mathbf{u}_j^*\| = \frac{r_0 - \mu_A t_j - \mu_S}{\sqrt{t_j^2 \sigma_A^2 + \sigma_S^2}}$, $\boldsymbol{\alpha}_j = \left(\frac{t_j \sigma_A}{\sqrt{t_j^2 \sigma_A^2 + \sigma_S^2}}, \frac{\sigma_S}{\sqrt{t_j^2 \sigma_A^2 + \sigma_S^2}} \right)$.
 - $\Pr(F_j^*) \approx \Pr\{G_j(\mathbf{U}) \leq 0\} = \Phi(-\beta_j)$.
 - $\Pr(F(T)) \approx 1 - \Phi_m(\boldsymbol{\beta}; \boldsymbol{\rho})$ where $\boldsymbol{\beta} = (\beta_1, \dots, \beta_m)$ and $[\boldsymbol{\rho}]_{j,k} = \alpha_{A,j} \alpha_{A,k} = \frac{t_j t_k \sigma_A^2}{\sqrt{t_j^2 \sigma_A^2 + \sigma_S^2} \sqrt{t_k^2 \sigma_A^2 + \sigma_S^2}}$

Example 2 (3)



FORM series system reliability bounds: $\max_{j=1,\dots,m} \Pr(F_j^*) \leq \Pr(F(T)) \leq 1 - \prod_{j=1}^m (1 - \Pr(F_j^*))$

Outcrossing theory-based approach

Consider the failure event:

$$F(T) = \{\exists t \in [0, T]: \min_{0 \leq t \leq T} g(\mathbf{Y}, t) \leq 0\}$$

where $g(\mathbf{Y}, t) = 0$ is the limit state. \mathbf{Y} is comprised of all random variables and random processes in the structural reliability problem.

In the general case, $g(\mathbf{Y}, t)$ is a random process. Let $N(t)$ denote the number of out-crossings of $g(\mathbf{Y}, t)$ from the safe state to the unsafe state in the time duration $(0, t]$.

The probability of failure for the time duration $[0, T]$ can be evaluated based on out-crossing theory:

$$P_F(0, T) = \Pr(\{g_0 \leq 0\} \cup \{N(T) > 0\}) = 1 - (1 - \Pr\{g_0 \leq 0\})\Pr\{N(T) = 0 | g_0 \geq 0\}$$

g_0 is the limit state function value at $t = 0$. Failure in the time interval $[0, T]$ corresponds either to failure at $t = 0$ or to a later outcrossing of the limit state surface if the system is in safe state at $t = 0$.

The Poisson approximation

- For a regular process $g(\mathbf{Y}, t)$, the outcrossing rate $\nu(t)$ is defined as:

$$\nu(t) = \lim_{\Delta t \rightarrow 0, \Delta t > 0} \frac{\Pr\{N(t+\Delta t) - N(t) = 1\}}{\Delta t} = \lim_{\Delta t \rightarrow 0, \Delta t > 0} \frac{\Pr(\{g_t > 0\} \cap \{g_{t+\Delta t} \leq 0\})}{\Delta t}$$

- The expected number of outcrossings in the time interval $(0, t]$ is given by $E[N(t)] = \int_0^t \nu(\tau) d\tau$.
- If the occurrence of outcrossings is modeled by a Poisson point process
 - the probability of no outcrossing in time interval $(0, T]$ is approximated as:

$$\Pr\{N(T) = 0 | g_0 \geq 0\} = \frac{\left[\int_0^T \nu(t) dt\right]^0 e^{-\int_0^T \nu(t) dt}}{0!} = e^{-\int_0^T \nu(t) dt}$$

- the failure probability for the time interval $[0, T]$ is approximately evaluated as:

$$P_F(0, T) = 1 - (1 - \Pr\{g_0 \leq 0\}) e^{-\int_0^T \nu(t) dt}$$

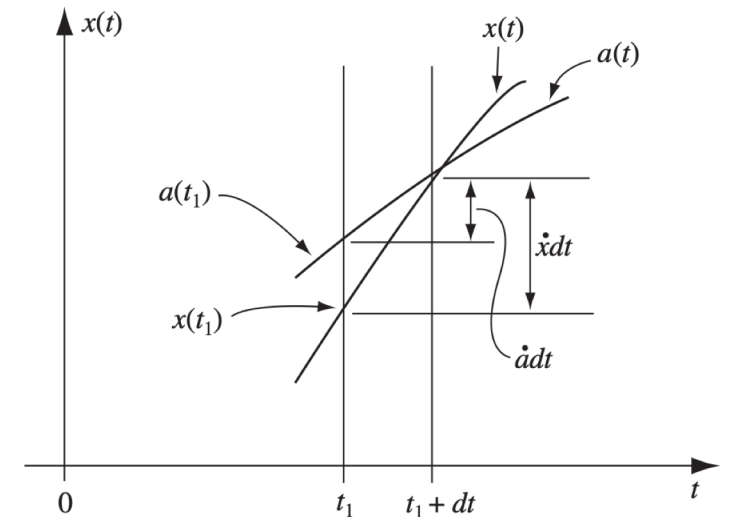
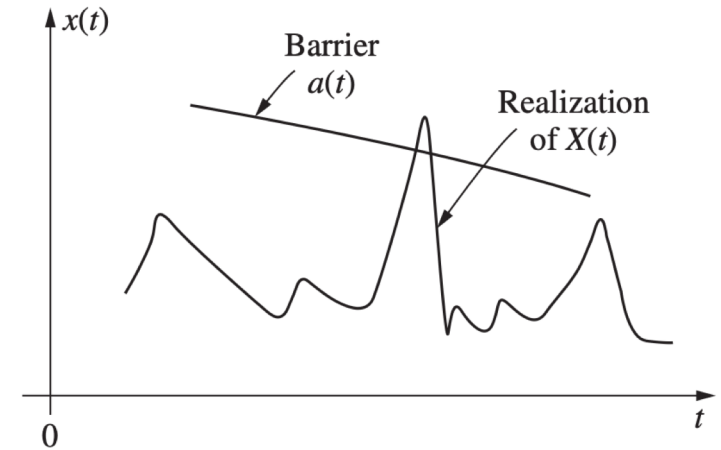
- The probability $\Pr\{g_0 \leq 0\}$ can be evaluated using time-invariant reliability methods.

Outcrossing rate: Rice's formula

We consider $g(\mathbf{Y}, t) = a(t) - G(\mathbf{Y}, t)$, i.e., failure occurs when the process $G(\mathbf{Y}, t)$ outcrosses the barrier $a(t)$.

Define $X(t) \equiv G(\mathbf{Y}, t)$. It is assumed $X(t)$ is differentiable.

- Consider a segment of the sample $x(t)$ between the time instants t_1 and $t_1 + dt$.
- For sufficiently small dt , the curves can be taken as straight lines:
 - $x(t_1 + dt) = x(t_1) + \dot{x}dt$
 - $a(t_1 + dt) = a(t_1) + \dot{a}dt$
- Outcrossing occurs at time $t_1 + dt$:
 - $x(t_1) \leq a(t_1)$
 - $x(t_1 + dt) \geq a(t_1 + dt)$, i.e., $\dot{x}dt - \dot{a}dt \geq a(t_1) - x(t_1)$



Outcrossing rate: Rice's formula

- Number of out-crossings in the time interval dt :

$$N = \int_{\dot{a}}^{\infty} \int_{a - (\dot{a} - \dot{x})dt}^a f_{X\dot{X}}(x, \dot{x}; t_1) dx d\dot{x}$$

$f_{X\dot{X}}(x, \dot{x}; t_1)$ is the joint PDF of $X(t)$ and $\dot{X}(t)$ at $t = t_1$

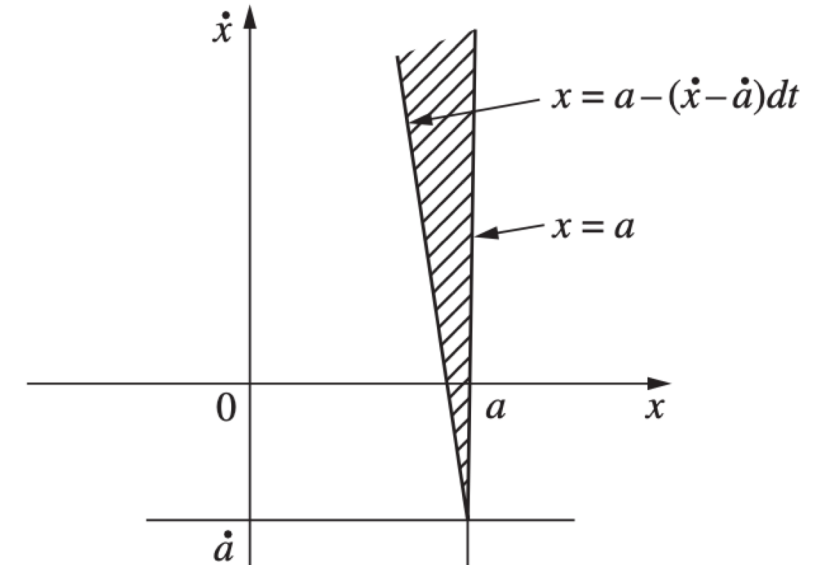
- As $dt \rightarrow 0$, $f_{X\dot{X}}(x, \dot{x}; t_1)$ can be approximated by $f_{X\dot{X}}(a, \dot{x}; t_1)$ over the range $a - (\dot{a} - \dot{x})dt \leq x \leq a$:

$$N = \int_{\dot{a}}^{\infty} (\dot{a} - \dot{x}) dt f_{X\dot{X}}(a, \dot{x}; t_1) d\dot{x}$$

- Outcrossing rate at time $t = t_1$:

$$\nu(t_1) = \lim_{dt \rightarrow 0} \frac{N}{dt} = \int_{\dot{a}}^{\infty} (\dot{a} - \dot{x}) f_{X\dot{X}}(a, \dot{x}; t_1) d\dot{x}$$

- If a is time-independent, $\dot{a} = 0$.
- Knowledge of $f_{X\dot{X}}(a, \dot{x}; t_1)$ for all $t_1 \in (0, T]$ is required.



Special case of a Gaussian process

- If $X(t)$ is a stationary Gaussian process:

- $\mu_X(t) = E[X(t)] \equiv \mu_X$, $\sigma_X^2(t) = E\left[(X(t) - \mu_X(t))^2\right] \equiv \sigma_X^2$, $\mu_{\dot{X}}(t) = 0$ and $\sigma_{\dot{X}}^2(t) \equiv \sigma_{\dot{X}}^2$.

- The random variables $X(t)$ and $\dot{X}(t)$ are independent:

$$f_{X\dot{X}}(a(t_1), \dot{x}; t_1) = \frac{1}{2\pi\sigma_X\sigma_{\dot{X}}} \exp\left\{-\frac{1}{2}\left[\left(\frac{a(t_1)-\mu_X}{\sigma_X}\right)^2 + \frac{\dot{x}^2}{\sigma_{\dot{X}}^2}\right]\right\}$$

- If $a(t) \equiv a$, the outcrossing rate $\nu(t) = \frac{\sigma_{\dot{X}}}{2\pi\sigma_X} \exp\left\{-\frac{1}{2}\left(\frac{a-\mu_X}{\sigma_X}\right)^2\right\}$, for all $t \in (0, T]$.

- If $X(t)$ is a non-stationary Gaussian process:

$$\nu(t) = \frac{\sigma_{\dot{X}}(t)\sqrt{1-\rho_{X\dot{X}}^2(t)}}{\sigma_X(t)} \phi\left(\frac{a(t)-\mu_X(t)}{\sigma_X(t)}\right) \left\{\phi(-h(t)) + h(t)\Phi(h(t))\right\}$$

where $h(t) = \frac{\rho_{X\dot{X}}(t)(a(t)-\mu_X(t))}{\sigma_X(t)\sqrt{1-\rho_{X\dot{X}}^2(t)}}$ and $\rho_{X\dot{X}}(t)$ is the correlation coefficient between $X(t)$ and $\dot{X}(t)$.

Example 3 - Linear dynamic system

- Idealized SDOF structure:

$$m\ddot{X}(t) + c\dot{X}(t) + kX(t) = P(t)$$

Initial conditions: $X(0) = 0, \dot{X}(0) = 0$

- Failure event:

$$F(T) = \{\min_{0 \leq t \leq T} x^* - X(t) \leq 0\}$$

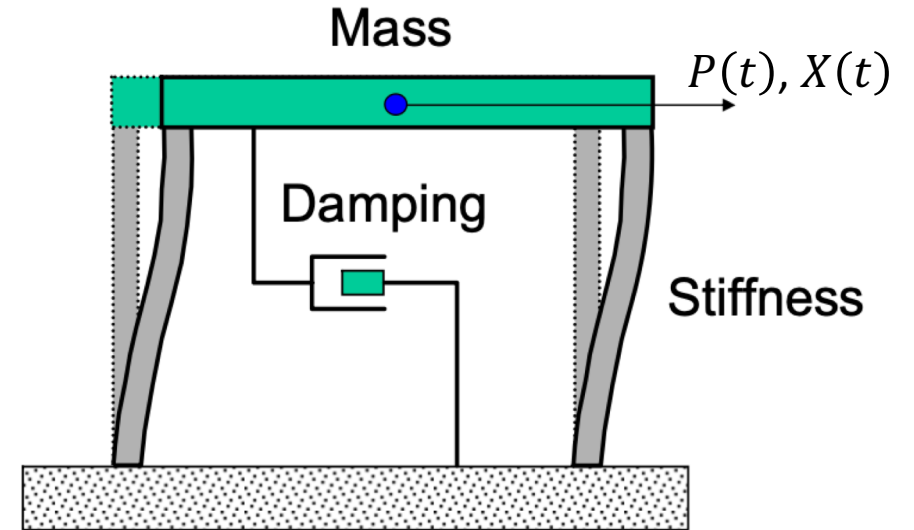
- Displacement $X(t)$ (assuming system is time-invariant):

$$X(t) = \int_0^t h_X(t - \tau)P(\tau)d\tau$$

$h_X(t)$ is the impulse response function, given by:

$$h_X(t) = \frac{1}{m\omega_d} e^{\eta\omega t} \sin(\omega_d t); t \geq 0$$

with $\omega = \sqrt{\frac{k}{m}}, \omega_d = \omega\sqrt{1 - \eta^2}, \eta = \frac{c}{2m\omega}$.



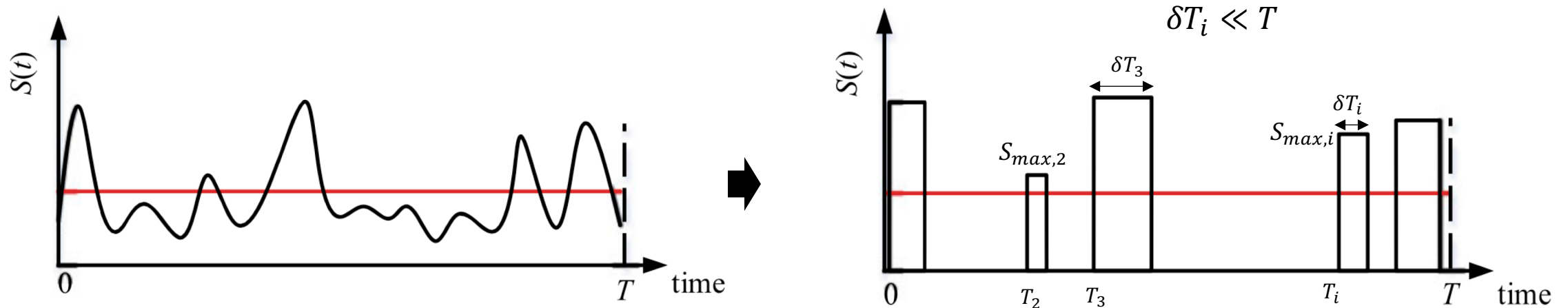
$P(t)$ is a Gaussian random process

Example 3 (2)

- We consider $P(t)$ is a Gaussian random process
 - $X(t)$ is a Gaussian random process
 - $\dot{X}(t) = \frac{d}{dt}X(t) = \int_0^t h_{\dot{X}}(t - \tau)P(\tau)d\tau$ is a Gaussian random process, where $h_{\dot{X}}(t) = \frac{d}{dt}h_X(t)$.
- Joint statistics of $X(t)$ and $\dot{X}(t)$:
 - $\mu_X(t) = E[X(t)] = \int_0^t h_X(t - \tau)\mu_P(\tau)d\tau$, where $\mu_P(t) = E[P(t)]$.
 - $\mu_{\dot{X}}(t) = E[\dot{X}(t)] = \int_0^t h_{\dot{X}}(t - \tau)\mu_P(\tau)d\tau$.
 - $\sigma_X^2(t) = E\left[(X(t) - \mu_X(t))^2\right] = \int_0^t \int_0^t h_X(t - \tau_1)K_{PP}(\tau_1, \tau_2)h_X(t - \tau_2)d\tau_1d\tau_2$.
 - $\sigma_{\dot{X}}^2(t) = \int_0^t \int_0^t h_{\dot{X}}(t - \tau_1)K_{PP}(\tau_1, \tau_2)h_{\dot{X}}(t - \tau_2)d\tau_1d\tau_2$
 - $\text{COV}(X(t), \dot{X}(t)) = E\left[(X(t) - \mu_X(t))(\dot{X}(t) - \mu_{\dot{X}}(t))\right] = \int_0^t \int_0^t h_X(t - \tau_1)K_{PP}(\tau_1, \tau_2)h_{\dot{X}}(t - \tau_2)d\tau_1d\tau_2$

where $K_{PP}(\tau_1, \tau_2) = E[(P(\tau_1) - \mu_P(\tau_1))(P(\tau_2) - \mu_P(\tau_2))]$.

Discretized approach: random number of discrete events



- The discretization is in terms of the number of occurrence of a particular event, e.g., a storm or an earthquake of a particular duration.
- The number of discrete events as well as the time of occurrence is random.
- The interval failure events: $F_j^*(\mathbf{T}) = \left\{ \min_{\tau \in (T_j, T_j + \delta T_j]} R(\tau) - S(\tau) \leq 0 \right\}$, where $\mathbf{T} = \{T_1, \dots, T_k\}$ is the random vector comprising of the occurrence time instants.

Load occurrence model

- Load occurrence is commonly modelled by a Poisson point process.
- For a stationary Poisson process with occurrence rate λ :
 - PMF of the number of loads in $[0, T]$ is $\Pr(N(T) = k) = \frac{(\lambda T)^k e^{-\lambda T}}{k!}; k = 0, 1, 2, \dots$
 - Joint PDF of the occurrence times is given by $f_{\mathbf{T}}(\mathbf{t}) = \left(\frac{1}{T}\right)^k$, where $\mathbf{t} = \{t_1, \dots, t_k\} \in [0, T]^k$.
- For a non-stationary Poisson process with time-variant occurrence rate $\lambda(t)$:
 - PMF of the number of loads in $[0, T]$ is $\Pr(N(T) = k) = \frac{\left(\int_0^T \lambda(t) dt\right)^k e^{-\int_0^T \lambda(t) dt}}{k!}; k = 0, 1, 2, \dots$
 - Joint PDF of the occurrence times is given by $f_{\mathbf{T}}(\mathbf{t}) = \prod_{j=1}^k \frac{\lambda(t_j)}{\int_0^T \lambda(t) dt}$, where $\mathbf{t} = \{t_1, \dots, t_k\} \in [0, T]^k$.

Solution approach

Consider the number of discrete events $N(T) = k$ and occurrence times $\mathbf{t} = (t_1, \dots, t_k) \sim f_{\mathbf{T}}(\mathbf{t})$.

The (conditional) time-dependent probability of failure:

$$\Pr(F(T|N(T) = k, \mathbf{T} = \mathbf{t})) = \Pr(\cup_{j=1}^k F_j^*(\mathbf{t}))$$

Considering the randomness in the load occurrence times, we get:

$$\Pr(F(T|N(T) = k)) = \int_0^T \dots \int_0^T \Pr(\cup_{j=1}^k F_j^*(\mathbf{t})) f_{\mathbf{T}}(t_1, \dots, t_k) dt_1 \dots dt_k$$

Taking into consideration the randomness associated with the number of load events:

$$\Pr(F(T)) = \sum_{k=0}^{\infty} \Pr(N(T) = k) \Pr(F(T|N(T) = k))$$

Summary

- Basic approaches for time-variant reliability analysis: time-integrated approach, discretized approach and outcrossing theory-based approach.
- The first two methods enable the failure probability over the whole service life of the structure to be evaluated using time-invariant reliability methods.
- The outcrossing theory-based approach establishes the limit state function as a random process. The time-variant reliability is solved as a first-passage problem based on the Poisson approximation.
- The outcrossing rate of the limit state function can be evaluated using alternative methods: Rice's formula, PHI2 method etc.
- Methods based on Monte Carlo simulation are more versatile for time-variant reliability estimation.

